

JL7018M Datasheet

Zhuhai Jieli Technology Co.,LTD

Version: 2.1

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JL7018M Features

CPU

- 32bit Dual-Core DSP
- Maximum speed 160MHz
- IEEE754 Single precision FPU
- Mathematical accelerate engine
- Interrupts with 8 priority level

Memory

- Support MMU
- Built-In Flash

Clocks

- On-chip 16 MHz clock oscillator
- On-chip 200 kHz lower-temperature-drift clock oscillator
- 24 MHz crystal oscillator

DSP Audio Processing

- LDAC, LHDC, SBC, AAC Audio decodes supported for BT audio
- mSBC voice codec supported for BT phone
- Supports MP2, MP3, WMA, APE, FLAC, AAC, MP4, M4A, WAV, AIF, AIFC audio decoding
- Packet Loss Concealment (PLC) for voice processing
- Single/Dual MIC Environmental Noise Cancellation (ENC)
- Multi-band DRC limiter
- Multi-band EQ configuration for voice Effects
- Support Hi-Res Audio

Audio Codec

- Two channels 24-bit DAC, SNR ≥ 104 dB
- Four channels 24-bit ADC, SNR ≥ 95 dB
- Audio DAC Sampling rates of 8kHz/11.025kHz/16kHz/22.05kHz/24kHz/32kHz/44.1kHz/48kHz/64kHz/88.2kHz/96kHz are supported
- Audio ADC Sampling rates of

8kHz/11.025kHz/16kHz/22.05kHz/24kHz/32kHz/44.1kHz/48kHz are supported

- Support four digital/analog MIC inputs
- Four channels analog audio inputs
- Audio DAC supports differential cap-less mode or single-ended mode
- Direct drive 16ohm/32ohm Speaker loading

ANC

- ANC processing engine up to 750 kHz sample rate
- 7.5 μ s analog to analog latency
- Supports 4 differential or single-ended analog inputs, 4 digital microphone inputs for ANC
- Supports 2 channels Feed-Forward, Feed-Back, Hybrid ANC
- ANC module include 20 double precision Biquad filters for each FF/FB/ music compensation control

Bluetooth

- Compliant with Bluetooth V6.0+BR+EDR+BLE specification (DN Q332415)
- Support AoA/AoD direction finding
- Support LE audio BIS/CIS full function
- Meet class1, class2, class3 transmitting power requirement
- Maximum +9dbm transmitting power
- EDR receiver with minimum -95dBm sensitivity
- Support a2dp\avctp\avdtp\avrcp\hfp\spp\smpt\att\gap\gatt\rfcomm\sdp\l2cap profile
bap 1.0.2\pacs 1.0.2\ccp 1.0\mcp 1.0\micp 1.0\vcp 1.0\csip 1.0.1\ascs 1.1\bass 1.0\cap 1.0\hap 1.0\pbp 1.0.1\map 1.0\lc3 1.0.1
a2dp 1.4\avctp 1.4\avdtp 1.3\ avrcp 1.6.3\ hfp 1.9\spp 1.2\rfcomm 1.2\pnp 1.3\ hid 1.1.1\sdp core 6.0\l2cap core 6.0

Peripherals

- One full speed USB OTG controller
- One SD host controller for eMMC/SD
- Six multi-function 32-bit timers, support capture and PWM mode
- Four UART interface, UART0,UART1&UART2 support DMA
- I2C Master/Slave interface
- SPI Master/Slave interface
- I2S Master/Slave interface
- QDEC
- Low power CapSense
- 12-channel 10-bit ADC for analog sampling
- 4-channel Motor PWM controller
- 24 Individually programmable and multiplexed GPIO pins
- Up to 12 external interrupt/wake-up source(low power available,can be multiplexed to any I/O)

PMU

- Built-in lithium battery charging manager,up to 200mA charging current
- Built-in LDO and Buck DC-DC converter
- Less than 2uA sleep current
- VPWR range : 4.5V to 5.5V
- VBAT range : 2.2V to 4.5V
- IOVDD range : 2.2V to 3.6V
- Conform with IEC 62368-1:2018 certification

Packages

- QFN40(5mm*5mm)

Temperature

- Operating temperature: -40°C to +85°C
- Storage temperature: -65°C to +150°C

Applications

- Bluetooth Stereo Headsets and Headphones
- Bluetooth Stereo ANC Headsets and Headphones
- Wireless microphone

1 Block Diagram

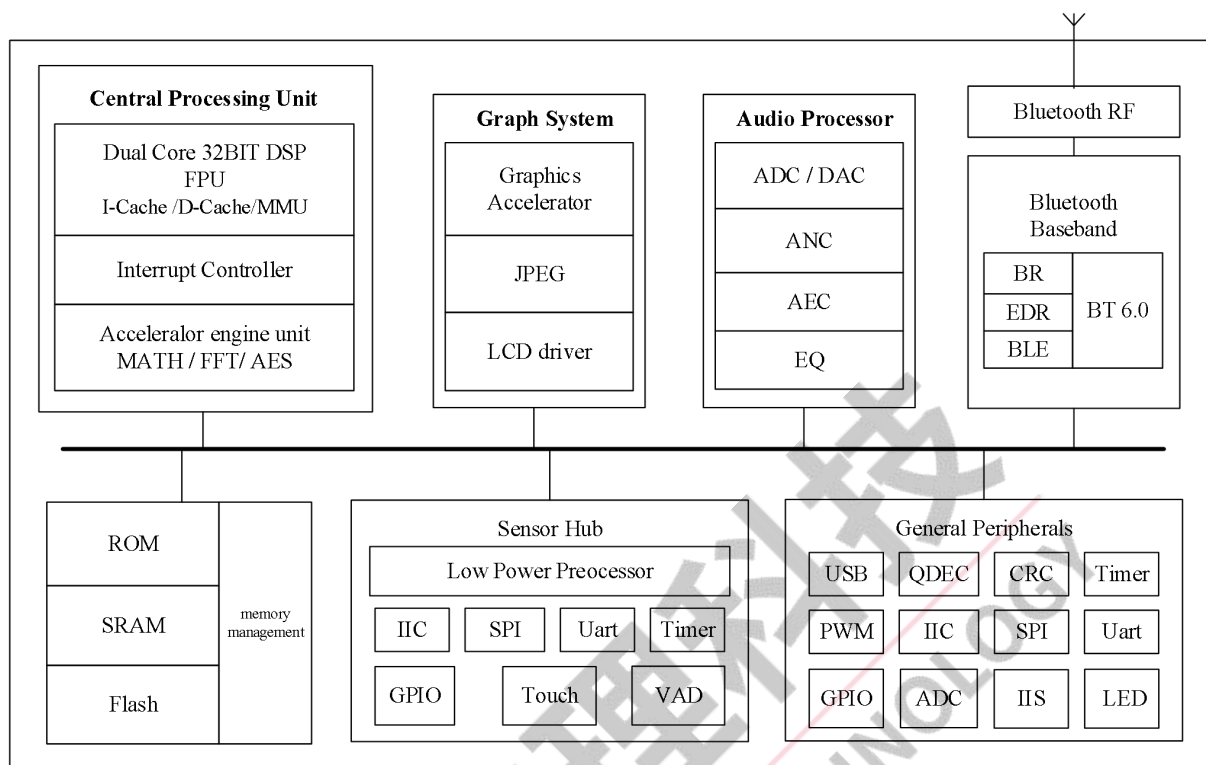


Figure 1-1 JL7018M Block Diagram

2 Pin Definition

2.1 Pin Assignment

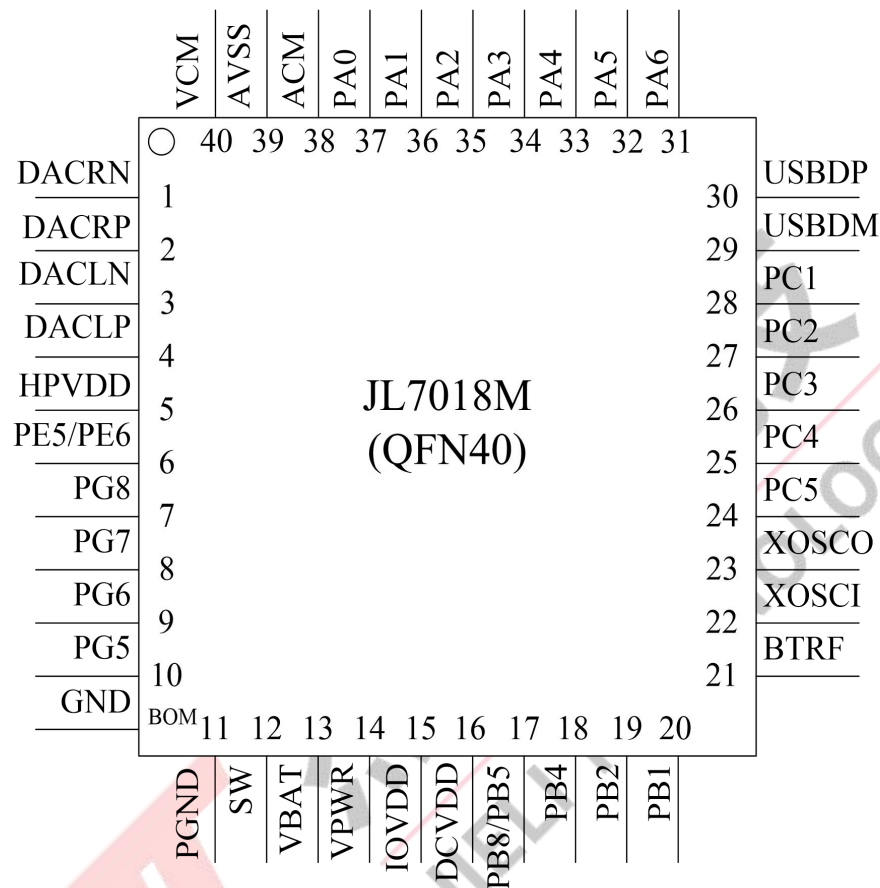


Figure 2-1 JL7018M Package Diagram

2.2 Pin Description

Table 2-1 JL7018M Pin Description

PIN NO.	Name	Type	Function	Other Function
1	DACRN	AO		Different DAC Right Negative Channel
2	DACRP	AO		Different DAC Right Positive Channel
3	DACLN	AO		Different DAC Left Negative Channel
4	DACLP	AO		Different DAC Left Positive Channel
5	HPVDD	PI		Audio power
6	PE6	I/O	GPIO	SDPG: supply voltage to SD Card
	PE5	I/O	GPIO	SPI4_D3(PSRAM): SPI4 Data3; SPI0_DAT3D: SPI0 Data3(D);
7	PG8	I/O	GPIO	MICIN2: MIC2 Input Channel 2; MIC2_P: Different MIC2 Positive; AMUX_C0: Analog Channel C0 input;
8	PG7	I/O	GPIO	MIC_BIAS2: MIC2 Bias Output(Built-in resistor); MIC2_N: Different MIC2 Negative; AMUX_C1: Analog Channel C1 input; ADC15: ADC Input Channel 15;
9	PG6	I/O	GPIO	MICIN3: MIC3 Input Channel3; MIC3_P: Different MIC3 Positive; AMUX_D0: Analog Channel D0 input; FPIN2: Fault Detect In2;
10	PG5	I/O	GPIO	MIC_BIAS3: MIC3 Bias Output(Built-in resistor); MIC3_N: Different MIC3 Negative; AMUX_D1: Analog Channel D1 input; ADC14: ADC Input Channel 14; TMR3CK: PWM Timer3 CLK In;
11	PGND	G		The ground of Buck DC-DC converter;
12	SW	PO		Switch signal of the Buck converter,connected to Inductor;
13	VBAT	P		Power Supply, connect to battery;
14	VPWR (PP0)	PI (I/O)	GPIO (High Voltage Resistant)	Charging Power Input; UART0TXB: Uart0 Data Out(B); UART0RXB: Uart0 Data In(B); PWM3: Timer3 PWM Output; CAP1: Timer1 Capture;
15	IOVDD	PO		Built-in linear voltage regulator output;
16	DCVDD	P		Internal Power;

17	PB8	I/O	GPIO	EVDD: Supply voltage 1.1V; CAP4: Timer4 Capture;
	PB5	I/O	GPIO	LP_Touch4: Low Power Touch Channel 4; IIC1_SDA_A: IIC1 SDA(A); ADC8: ADC Input Channel 8; UART3RXB: Uart3 Data In(B);
18	PB4	I/O	GPIO	LP_Touch3: Low Power Touch Channel 3; CLKOUT0: CLK Output Channel 0; SPI4DIA: SPI4 Data In(A); IIC1_SCL_A: IIC1 SCL(A); UART3TXB: Uart3 Data Out(B); TMR2: Timer2 Clock Input;
19	PB2	I/O	GPIO	LP_Touch2: Low Power Touch Channel 2; SPI4CLKA: SPI4 Clock(A); Q-decoder0_0: Quadrature decoder0_0; ADC7: ADC Input Channel 7; UART3TXA: Uart3 Data Out(A); CAP5: Timer5 Capture;
20	PB1	I/O	GPIO	Hold down 0 to reset; LP_Touch1: Low Power Touch Channel 1; ADC6: ADC Input Channel 6;
21	BTRF	RFI		Bluetooth RF antenna interface;
22	XOSCI	I		System Crystal Oscillator Input;
23	XOSCO	O		System Crystal Oscillator Output;
24	PC5	I/O	GPIO	SPI0_DAT2C: SPI0 Data2(C); SD0_CLKA: SD0 Clock(A); SPI1DOB: SPI1 Data Out(B); IIC0_SDA_B: IIC0 SDA(B); ALNK_DAT3(B): Audio Link Data3(B); ADC5: ADC Input Channel 5; UART2RXA: Uart2 Data In(A);
25	PC4	I/O	GPIO	SPI0_DIC: SPI0 Data In(C); SD0CMDA: SD0 CMD(A); SPI1CLKB: SPI1 Clock(B); IIC0_SCL_B: IIC0 SCL(B); ALNK_DAT2B: Audio Link Data2(B); ADC4: ADC Input Channel 4; UART2TXA: Uart2 Data Out(A); PWM4: Timer4 PWM Output;

26	PC3	I/O	GPIO	SPI0_CSC: SPI0 Chip Select(C); SD0DATOA: SD0 Data Out(A); SPI1DIB: SPI1 Data In(B); ALNK_LRCKB: Audio Link Word Select(B); TMR3: Timer3 Clock Input;
27	PC2	I/O	GPIO	SPI0_DOC: SPI0 Data Out(C); ALNK_SCLKB: Audio Link Serial Clock(B); TMR1: Timer1 Clock Input;
28	PC1	I/O	GPIO	SPI0_CLKC: SPI0 Clock(C); ALNK_DAT1B: Audio Link Data1(B); TMR5: Timer5 Clock Input; PWMCH1L: PWM CH1 Low;
29	USBDM	I/O	USB Negative Data (pull down)	SDTAP_DATB: SDTAP Data(B); SPI2DOB: SPI2 Data Out(B); IIC0_SDA_A: IIC0 SDA(A); ADC11: ADC Input Channel 11; UART1RXB: Uart1 Data In(B);
30	USBDP	I/O	USB Positive Data (pull down)	SDTAP_CLKB: SDTAP CLK(B); SPI2CLKB: SPI2 Clock(B); IIC0_SCL_A: IIC0 SCL(A); ADC10: ADC Input Channel 10; UART1TXB: Uart1 Data Out(B);
31	PA6	I/O	GPIO	PLNK_DAT0: PLNK Data 0; SPI2DOA: SPI2 Data Out(A); ALNK_DAT3A: Audio Link Data3(A); ADC2: ADC Input Channel 2; UART0RXA: Uart0 Data In(A); CAP0: Timer0 Capture;
32	PA5	I/O	GPIO	PLNK_SCLK: PLNK Serial Clock; SPI2CLKA: SPI2 Clock(A); ALNK_DAT2A: Audio Link Data2(A); ADC1: ADC Input Channel 1; UART0TXA: Uart0 Data Out(A);
33	PA4	I/O	GPIO	MIC_BIAS1: MIC1 Bias Output(Built-in resistor); MIC1_N: Different MIC1 Negative; AMUX_B1: Analog Channel B1 input; SPI2DIA: SPI2 Data In(A); ALNK_DAT1A: Audio Link Data1(A); CAP2: Timer2 Capture;

34	PA3	I/O	GPIO	MICIN1: MIC1 Input Channel 1; MIC1_P: Different MIC1 Positive; AMUX_B0: Analog Channel B0 input; SPI1DOA: SPI1 Data Out(A); ALNK_DAT0(A): Audio Link Data0(A); PWM1: Timer1 PWM Output;
35	PA2	I/O	GPIO	MIC_BIAS0: MIC0 Bias Output(Built-in resistor); MIC0_N: Different MIC0 Negative; AMUX_A1: Analog Channel A1 input; CLKOUT1: Clock Out1; SPI1CLKA: SPI1 Clock(A); ALNK_MCLKA: ALNK Master Clock(A); UART1RXA: Uart1 Data In(A); CAP3: Timer3 Capture;
36	PA1	I/O	GPIO	MICIN0: MIC0 Input Channel 0; MIC0_P: Different MIC0 Positive; AMUX_A0: Analog Channel A0 input; SPI1DIA: SPI1 Data In(A); UART1TXA: Uart1 Data Out(A); PWM0: Timer0 PWM Output;
37	PA0	I/O	GPIO	MICLDO: MIC Power Supply; ADC0: ADC Input Channel 0;
38	ACM	P		Audio analog reference bias;
39	AVSS	G		Audio analog ground;
40	VCM	P		Audio ADC/DAC reference;
PAD	VSS	G		System Ground;

Pin Type	Description	Pin Type	Description
P	Power	I/O	Input or Output
PO	Power Output	I	Input
PI	Power Input	O	Output
G	Ground	RFI	Radio frequency interface
AO	Analog Output		

3 Electrical Characteristics

3.1 Absolute Maximum Ratings

Table 3-1

Symbol	Parameter	Min	Max	Unit
T _{opt}	Operating temperature	-40	+85	°C
T _{stg}	Storage temperature	-65	+150	°C
VBAT	Supply Voltage	-0.3	4.5	V
VPWR	Charger Voltage	-0.3	6	V
V _{IOVDD}	Voltage applied at IOVDD	-0.3	3.6	V
V _{GPIO}	Voltage applied to GPIO	-0.3	IOVDD+0.3	V
V _{HVIO}	Voltage applied to High Voltage Resistant IO	-0.3	+5.5	V
V _{HPVDD}	Voltage applied at HPVDD	-0.3	+3	V

Note : The chip can be damaged by any stress in excess of the absolute maximum ratings listed below

3.2 PMU Characteristics

Table 3-2

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
VBAT	Voltage Input	2.2	3.7	4.4	V	
VPWR	Charger supply Voltage	4.5	5.0	5.5	V	
Operating mode						
IOVDD	Voltage output	—	3.0	—	V	VBAT = 4.2V, 10mA loading
	Loading current	—	—	200	mA	IOVDD=3.2V@VBAT = 3.5V
DCVDD	Voltage output	—	1.25	—	V	IOVDD=3.0V, 10mA loading
	Loading current	—	—	100	mA	DCVDD=1.25V@IOVDD=3.0v on LDO mode
		—	—	180	mA	DCVDD=1.25V@VBAT=3.0v on DCDC mode
EVDD	Voltage output	—	1.1	—	V	DCVDD=1.25V, 1mA loading
	Loading current	—	—	5	mA	EVDD=1.1V@DCVDD=1.25v
Low Power mode						
IOVDD	Loading current	—	—	10	mA	IOVDD=3V@VBAT = 4.2V

3.3 Battery Charge

Table 3-3

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
VPWR	Charge Input Voltage	4.5	5	5.5	V	—
V _{bat float}	Charge Voltage	4.15	4.2	4.25	V	VPWR > 4.5V
		4.30	4.35	4.40	V	VPWR > 4.65V
I _{bat}	Charge Current	15	—	200	mA	Charge current at fast charge mode VBAT=4.0V@VPWR=5.0V
I _{end}	End Of Charge Current	2	—	30	mA	End of charge current
V _{Trinkl}	Trickle Charge Voltage	—	3.0	—	V	VPWR > 4.5V
I _{Trinkl}	Trickle Charge Current	1.5	—	30	mA	V _{BAT} < V _{Trinkl}

3.4 IO Input/Output Electrical Logical Characteristics

Table 3-4

GPIO input characteristics						
Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
V _{IL}	Low-Level Input Voltage	-0.3	—	0.3* IOVDD	V	IOVDD = 3.0V
V _{IH}	High-Level Input Voltage	0.7* IOVDD	—	IOVDD+0.3	V	IOVDD = 3.0V
High Voltage Resistant IO input characteristics						
Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
V _{IL}	Low-Level Input Voltage	-0.3	—	0.3* IOVDD	V	IOVDD = 3.0V
V _{IH}	High-Level Input Voltage	0.7* IOVDD	—	+5V	V	IOVDD = 3.0V
GPIO & High Voltage Resistant IO output characteristics						
Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
V _{OL}	Low-Level Output Voltage	—	—	0.1* IOVDD	V	IOVDD = 3.0V
V _{OH}	High-Level Output Voltage	0.9* IOVDD	—	—	V	IOVDD = 3.0V

3.5 Internal Resistor Characteristics

Table 3-5

Port	Drive(mA)		Internal Pull-Up Resistor	Internal Pull-Down Resistor	Comment
PA0~PA6	HD,HD0==0,0	2.4	10K	10K	1、PB1 default pull up 2、USBDM & USBDP default pull Down 3、internal pull-up / pull-down resistance accuracy ±20%
PC1~PC5	HD,HD0==0,1	8			
PG5~PG8	HD,HD0==1,0	26			
PE5 , PE6	HD,HD0==1,1	46			
PP0	8		10K	10K	
PB1~PB8	8		10K	10K	
USBDP	4		1.5K	15K	
USBDM			180K	15K	

3.6 DAC Characteristics

Table 3-6

Parameter	Min	Typ	Max	Unit	Audio Format	Test Conditions
Frequency Response	20	—	20k	Hz	—	Differential Mode 1KHz/0dB 32 ohm loading With A-Weighted Filter
Output Swing	—	1	—	Vrms	—	
THD+N	—	-77	—	dB	PCM	
	—	-70	—	dB	SBC	
S/N	—	105	—	dB	PCM	
	—	105	—	dB	SBC	
Crosstalk	—	-110	—	dB	—	1KHZ/0dB 10k ohm loading
Dynamic Range	—	104	—	dB	PCM	Differential Mode 1KHz/-60dB 32 ohm loading With A-Weighted Filter
	—	104	—	dB	SBC	
Noise Floor	—	5.6	—	uVrms	—	A-Weighted Filter
DAC Output Power	—	32	50	mW	—	Differential Mode 32ohm loading

3.7 ADC Characteristics

Table 3-7

Parameter	Min	Typ	Max	Unit	Test Conditions
Dynamic Range		94		dB	Fsample=44.1kHz, Gain=0dB Fin=1KHz 590mVrms
SNR	—	95	—	dB	Fsample=44.1kHz, Gain=0dB Fin=1KHz 590mVrms
THD+N	—	-75	—	dB	
SNR	—	76	—	dB	Fsample=44.1kHz, Gain=18dB Fin=1KHz 75mVrms
THD+N	—	-73	—	dB	

3.8 BT Characteristics

3.8.1 Transmitter

Basic Rate

Table 3-8

Parameter	Min	Typ	Max	Unit	Test Conditions
RF Transmit Power		7	9	dBm	25℃, Power Supply VBAT=3.7V 2441MHz
RF Power Control Range		18		dB	
20dB Bandwidth		950		KHz	
In-band spurious	F=F ₀ ±1MHz	-22		dBm	
Emissions	F=F ₀ ±2MHz	-51		dBm	
(BQB Test Mode RF_Tx Power=5dBm)	F=F ₀ ±3MHz	-55		dBm	
	F=F ₀ +/->3MHz	-55		dBm	

Enhanced Data Rate

Table 3-9

Parameter	Min	Typ	Max	Unit	Test Conditions
Relative Power		-2		dB	25℃, Power Supply VBAT=3.7V 2441MHz
$\pi/4$ DQPSK Modulation Accuracy	DEVM RMS	7		%	
	DEVM 99%	17		%	
	DEVM Peak	14		%	
In-band spurious	F=F ₀ ±1MHz	-4		dBm	
Emissions	F=F ₀ ±2MHz	-34		dBm	
(BQB Test Mode RF_Tx Power=5dBm)	F=F ₀ ±3MHz	-43		dBm	
	F=F ₀ +/->3MHz	-48		dBm	

3.8.2 Receiver

Basic Rate

Table 3-10

Parameter		Min	Typ	Max	Unit	Test Conditions
Sensitivity			-92		dBm	25°C, Power Supply VBAT=3.7V 2441MHz DH5
Co-channel Interference Rejection			10		dB	
Adjacent channel selectivity C/I	+1MHz		-4		dB	
	-1MHz		-3		dB	
	+2MHz		-39		dB	
	-2MHz		-33		dB	
	+3MHz		-45		dB	
	-3MHz		-28		dB	

Enhanced Data Rate

Table 3-11

Parameter		Min	Typ	Max	Unit	Test Conditions
Sensitivity		-95	-94		dBm	25°C, Power Supply VBAT=3.7V 2441MHz 2DH5
Co-channel Interference Rejection			10		dB	
Adjacent channel selectivity C/I	+1MHz		-8		dB	
	-1MHz		-8		dB	
	+2MHz		-40		dB	
	-2MHz		-33		dB	
	+3MHz		-45		dB	
	-3MHz		-27		dB	

3.8.3 BLE

1M Data Rate

Table 3-12

Parameter		Min	Typ	Max	Unit	Test Conditions
Sensitivity			-96		dBm	25°C Power Supply VBAT=3.7V 2440MHz
RF Transmit Power			7		dBm	
In-band Spurious Emission	M-N =2MHz		-39		dBm	
	M-N ≥3MHz			-41	dBm	
Modulation Characteristics	Δf1 avg		250		KHz	
	Δf2 99%		209		KHz	
	Δf1avg/Δf2avg		0.9			
Carrier Frequency Offset		-10		+10	KHz	
Frequency Drift		-10		+10	KHz	
Frequency Drift Rate		-5		+5	KHz/50us	

2M Data Rate

Table 3-13

Parameter		Min	Typ	Max	Unit	Test Conditions
Sensitivity			-94		dBm	25°C Power Supply VBAT=3.7V 2441MHz
RF Transmit Power			7		dBm	
In-band Spurious Emission	M-N =4MHz		-44		dBm	
	M-N =5MHz		-41		dBm	
	M-N ≥6MHz			-43	dBm	
Modulation Characteristics	Δf1 avg		500		KHz	
	Δf2 99%		422		KHz	
	Δf1avg/Δf2avg		0.9			
Carrier Frequency Offset		-10		+10	KHz	
Frequency Drift		-15		+15	KHz	
Frequency Drift Rate		-5		+5	KHz/50us	

Long Range

Table 3-14

Parameter	Min	Typ	Max	Unit	Test Conditions
Sensitivity LE 125K(S8)		-104		dBm	VBAT=3.7V,25°C 2441MHz
Sensitivity LE 500K(S2)		-100		dBm	

3.9 ESD Protection

Table 3-15

Parameter	Typ.	Test pin	Reference standard
Human Body Mode	±4KV	All pins	JEDEC EIA/JESD22-A114
Machine Mode	±200V	All pins	JEDEC EIA/JESD22-A115
Charge Device Model	±1KV	All pins	JEDEC EIA/JESD22-C101F
Latch up	±200mA	All GPIO pins	JEDEC STANDARD NO.78E
	1.5xVopmax	All power pins	

Note : 1.5xVopmax = 1.5 times maximum operating voltage.

4 Package Information

4.1 QFN40_5.0x5.0

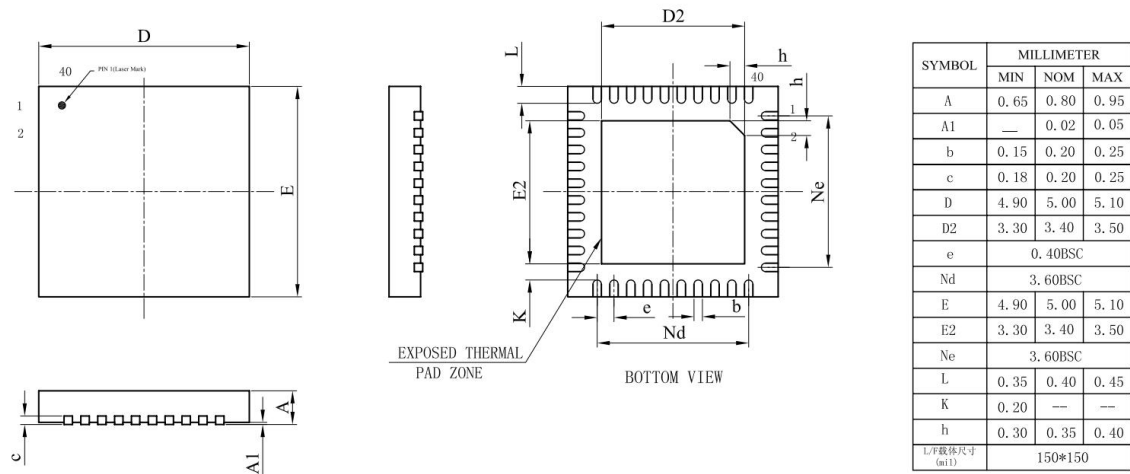
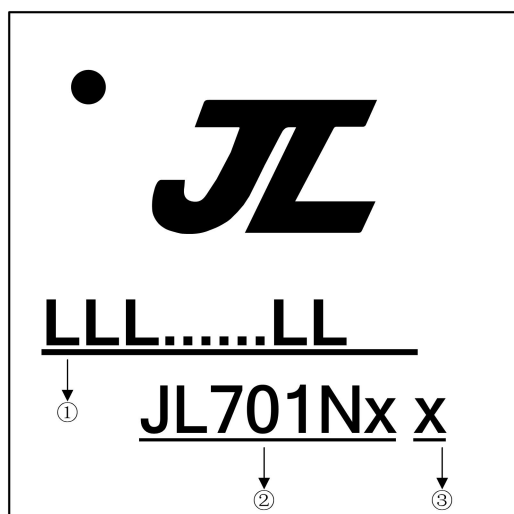


Figure 4-1 JL7018M Package

5 IC Marking Information



- ① LLL.....LL: LOT No. , It contains 7 to 18 alphanumerics
- ② JL701Nx: Chip Model
- ③ x: Built-in flash size
 - 0: No Flash Memory
 - 2: 2Mbit Flash
 - 4: 4Mbit Flash
 - 8: 8Mbit Flash
 - 6: 16Mbit Flash
 - 3: 32Mbit Flash

6 Solder-Reflow Condition

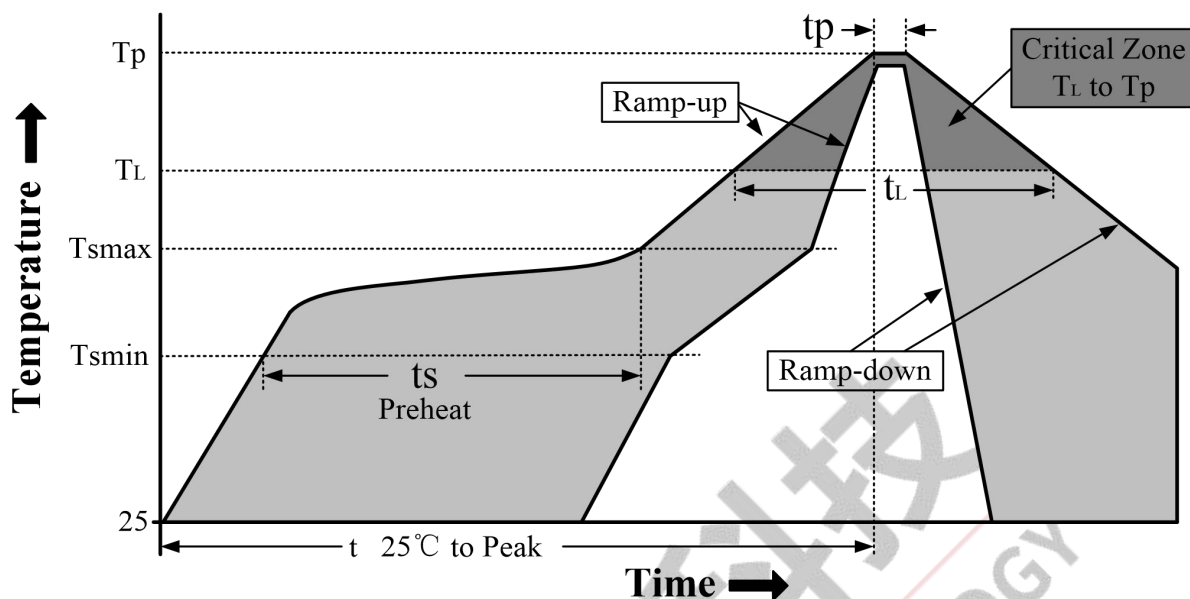


Figure 6-1 Classification Reflow Profile

Classification Profiles

Table 6-1

Profile Feature		Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat/ Soak	Temperature Min (T_{smin})	100°C	150°C
	Temperature Max (T_{smax})	150°C	200°C
	Time (t_s) from (T_{smin} to T_{smax})	60-120 seconds	60-180 seconds
Average ramp-up rate (T_{smax} to T_p)		3°C/second max	3°C/second max
Liquidous temperature (T_L)		183°C	217°C
Time (t_L) maintained above T_L		60-150 seconds	60-150 seconds
Peak package body temperature (T_p)		See Table 6-2	See Table 6-3
Time within 5°C of actual Peak Temperature (t_p) ²		10-30 seconds	20-40 seconds
Ramp-down rate (T_p to T_L)		6°C/second max	6°C/second max
Time 25°C to peak temperature		6 minutes max	8 minutes max

Note 1: All temperatures refer to topside of the package, measured on the package body surface.

Note 2: Time within 5°C of actual peak temperature (t_p) specified for the reflow profiles is a “supplier” minimum and “user” maximum.

SnPb - Classification Temperature

Table 6-2

Package Thickness	Volume mm ³ < 350	Volume mm ³ ≥ 350
<2.5 mm	240 +0/-5°C	225 +0/-5°C
≥2.5 mm	225 +0/-5°C	225 +0/-5°C

Pb-free - Classification Temperature

Table 6-3

Package Thickness	Volume mm³ < 350	Volume mm³ 350 - 2000	Volume mm³ > 2000
< 1.6mm	260℃	260℃	260℃
1.6 mm - 2.5mm	260℃	250℃	245℃
> 2.5mm	250℃	245℃	245℃

7 Storage Condition

7.1 Moisture Sensitivity Level

JL7018M is qualified to moisture sensitivity level MSL3 in accordance with JEDEC J-STD-033.

7.2 Storage Alert

1. Calculated shelf life in sealed bag 12 months at $\leq 40^{\circ}\text{C}$ and 90% relative humidity (RH).
2. Peak package body temperature $\leq 260^{\circ}\text{C}$.
3. After bag is opened, devices that will be subjected to reflow solder or other high temperature process must be mounted within 168 hours of factory conditions $\leq 30^{\circ}\text{C}/60\%\text{RH}$ or stored per J-STD-033.
4. Devices require bake before mounting if humidity indicator card reads $> 10\%$ for level 2a-5a devices or $> 60\%$ for level 2 devices when read at $23 \pm 5^{\circ}\text{C}$, or 3a or 3b are not met.
5. Please refer to IPC/JEDEC J-STD-033 for baking procedure if necessary.

8 Revision History

Date	Revision	Description
2022.07.20	V1.0	Initial Release
2022.09.20	V1.1	Add Storage Condition and ESD Protection; Update IC Marking Information and BT characteristics
2023.02.22	V1.2	Update Features and Pin Description
2023.03.01	V1.3	Update Features
2023.10.17	V1.4	Update JL7018M BT_Features
2023.12.29	V1.5	Update JL7018M BT_Features (Meet class1 transmitting power requirement)
2024.08.09	V1.6	Update Audio & PMU_Features Update IC Marking Information
2025.01.15	V2.0	Update Bluetooth Vision and profiles
2025.06.23	V2.1	Update Package Information